

Agilent E8267D PSG Vector Signal Generator

Data Sheet



The Agilent E8267D is a fully synthesized signal generator with high output power, low phase noise, and I/Q modulation capability.

All specifications apply over a 0 to 55 °C range (unless otherwise stated) and apply after a 45 minute warm-up time. Supplemental characteristics, denoted as typical, nominal, or measured, provide additional (non-warranted) information at 25 °C, which may be useful in the application of the product.

Definitions

Specifications (spec): Represents warranted performance.

Typical (typ): Represents characteristic performance which is non-warranted. Describes performance that will be met by a minimum of 80% of all products.

Nominal (nom): Represents characteristic performance which is non-warranted. Represents the value of a parameter that is most likely to occur; the expected mean or average.

Measured: Represents characteristic performance which is non-warranted. Represents the value of a parameter measured on an instrument during design stage.



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Specifications

Frequency

Range ¹				
Option 520	250 kHz to 20 GHz			
Option 532	250 kHz to 31.8 GHz			
Option 544	250 kHz to 44 GHz			
Resolution				
CW	0.001 Hz			
All sweep modes	0.01 Hz ²			
Switching speed ^{3,4}	< 16 ms (typ) with I/Q r	modulation off		
e	< 24 ms (typ) with $1/Q$ r			
Phase offset	Adjustable in nominal 0			
Frequency bands				
Band	Frequency range	N #		
1	250 kHz to 250 MHz	1/8		
2	> 250 to 500 MHz	1/16		
- 3	> 500 MHz to 1 GHz	1/8		
4	> 1 to 2 GHz	1/4		
5	> 2 to 3.2 GHz	1/2		
6	> 3.2 to 10 GHz	1		
7	> 10 to 20 GHz	2		
8	> 20 to 28.5 GHz	3		
9	> 28.5 to 44 GHz	5		
Accuracy	Calibration ± aging rate ± temperature effe ± line voltage effects (nom)			
Internal timebase reference oscil	lator	,		
	Standard	Option UNR		
Aging rate	$< \pm 1 \times 10^{-7}$ /year or	< ±3 x10 ⁻⁸ /year or		
	< ±4.5 x 10 ^{.9} /day	< ±2.5 x 10 ⁻¹⁰ /day		
	after 45 days	after 30 days		
Temperature effects (typ)	< ±5 x 10 ⁻⁸ 0 to 55 °C	< ±4.5 x 10 ^{.9} 0 to 55 °C		
Line voltage effects (typ)	< ±2 x 10 ^{.9} for	< ±2 x 10 ⁻¹⁰		
	+5% to -10% change	for ±10% change		
External reference frequency	1, 2, 2.5, 5, 10 MHz	10 MHz only		
Lock range	±0.2 ppm	±1.0 ppm		
Reference output	••			
Frequency	10 MHz			
Amplitude	> +4 dBm into 50 Ω loa	id (typ)		
External reference input				
Amplitude	> –3 dBm			
Option UNR	5 dBm ±5 dB⁵			
	50 Ω (nom)			

Step (digital) sweep

Operating modes	Step sweep of frequency or amplitude or both (start to stop)		
	List sweep of frequency or amplitude or both (arbitrary list)		
Sweep range			
Frequency sweep	Within instrument frequency range		
Amplitude sweep	Within attenuator hold range (see "Output" section)		
Dwell time	1 ms to 60 s		
Number of points	2 to 65535 (step sweep)		
	2 to 1601 per table (list sweep)		
Triggering	Auto, external, single, or GPIB		
Settling time			
Frequency	< 8 ms ⁶ (typ)		
Amplitude	< 5 ms (typ)		

1. Operational, but unspecified, down to 100 kHz.

In ramp sweep mode (Option 007), resolution is limited with narrow spans and slow sweep 2.

speeds. Refer to ramp sweep specifications for more information. Time from GPIB trigger to frequency within 0.1 ppm of final frequency above 250 MHz or within 3. 100 Hz below 250 MHz.

4. Add 12 ms (typ) when switching from greater than 3.2 GHz to less than 3.2 GHz.

5.

To optimize phase noise 5 dBm \pm 2 dB. 19 ms (typ) when stepping from greater than 3.2 GHz to less than 3.2 GHz. 6.

Ramp (analog) sweep

(Option 007)¹

4

Operating modes Synthesized frequency sweep				
(start/stop), (center/span), (swept CW)				
	Power (ampli	tude) sweep (start/stop)	
	Manual swee	ep		
	RPG control I	Detween start and stop f	requencies	
	Alternate sw	eep	•	
	Alternates su	iccessive sweeps betwe	en current and	
	stored states			
Sweep span range	Settable from	1 minimum ² to full range		
Maximum sweep rate	Start frequency	Maximum sweep rate	Max span for	
			100 ms sweep	
	250 kHz to < 0.5 GHz	25 MHz/ms	2.5 GHz	
	0.5 to < 1 GHz	50 MHz/ms	5 GHz	
	1 to < 2 GHz	100 MHz/ms	10 GHz	
	2 to < 3.2 GHz	200 MHz/ms	20 GHz	
	\geq 3.2 GHz	400 MHz/ms	40 GHz	
Frequency accuracy	± 0.05% of sp	oan ± timebase (at 100 m	ns sweep time, for	
	sweep spans	sweep spans less than maximum values given above)		
		roves proportionally as sv		
Sweep time		p, not including bandswitch	and retrace intervals	
Manual mode	Settable 10 n	ns to 200 seconds		
Resolution	ution 1 ms			
Auto mode	Set to minim	um value determined by	maximum sweep	
	rate and 8757			
Triggering		I, single, or GPIB		
Markers		ent continuously variable		
Display		ity or RF amplitude pulse		
Functions		M1 to center, M1/M2 to start/stop, marker delta		
Two-tone (master/slav	,			
measurements ⁴		Two PSGs can synchronously track each other, with		
		control of start/stop free		
Network analyzer compa	• • •	ble with Agilent 8757D s	scalar	
	network anal	•		
		with Agilent 8757A/C/E		
	analyzers for	making basic swept mea	asurements. ⁶	

^{1.} During ramp sweep operation, AM, FM, phase modulation, and pulse modulation are useable but performance is not specified; wideband AM and I/Q modulation are not useable.

Minimum settable sweep span is proportional to carrier frequency and sweep time. Actual sweep span may be slightly different than desired setting for spans less than [0.00004% of carrier frequency or 140 Hz] x [sweep time in seconds]. Actual span will always be displayed correctly.

Typical accuracy for sweep times > 100 ms can be calculated from the equation: [(0.005% of span)/(sweep time in seconds)] ± timebase. Accuracy is not specified for sweep times < 100 ms.

For master/slave operation, use Agilent part number 8120-8806 master/slave interface cable.
 When measuring low-pass devices in AC mode, dynamic range may be reduced up to 10 dB

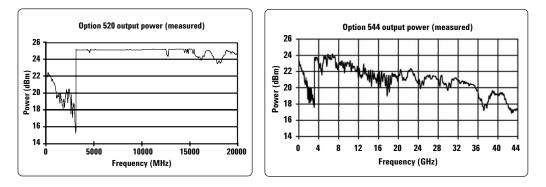
below 3.2 GHz. An external highpass filter may be required to remove 27 kHz pulse source feed-through (11742A 45 MHz to 26.5 GHz blocking capacitor recommended).

GPIB system interface is not supported with 8757A/C/E, only with 8757D. As a result, some features of the 8757A/C/E, such as frequency display, pass-through mode, and alternate sweep, do not function with PSG signal generators.

0	ut	n		t
v	uı	μ	u	L

Power ^{1,2} (dBm)	
Frequency range	spec (typ)
Option 520	
250 kHz to 3.2 GHz	-130 to +13 (+16)
250 kHz to 3.2 GHz with Option UNW	-130 to +9 (+13)
250 kHz to 3.2 GHz with Option 1EH	-130 to +10 (+13) ³
250 kHz to 3.2 GHz with Options UNW and 1EH	-130 to +7 (+12) ³
> 3.2 to 10 GHz	-130 to +18 (+23) ⁴
> 10 to 20 GHz	-130 to +18 (+22) ⁴
Options 532 and 544	
250 kHz to 3.2 GHz	-130 to +12 (+15)
250 kHz to 3.2 GHz with Option UNW	-130 to +8 (+12)
250 kHz to 3.2 GHz with Option 1EH	-130 to +9 (+12) ³
250 kHz to 3.2 GHz with Options UNW and 1EH	-130 to +6 (+11) ³
> 3.2 to 10 GHz	–130 to +14 (+21) ^{4,}
> 10 to 20 GHz	-130 to +14 (+18) ^{4,}
> 20 to 32 GHz	–130 to +14 (+18)⁵
> 32 to 40 GHz	-130 to +12 (+18)⁵
> 40 to 44 GHz	−130 to +10 (+13) ⁵
Step attenuator ⁶	0 to 115 dB in 5 dB steps

Maximum available power in CW mode (measured)

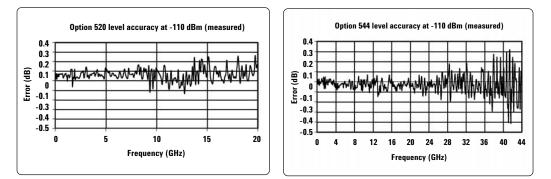


Attenuator hold range	
Minimum	From –15 dBm to maximum specified output power with step attenuator in 0 dB position. Can be offset using step
	attenuator.
Amplitude switching speed ⁷	
ALC on or off (without power search)	< 3 ms (typ)

- Maximum power specification is warranted from 15 to 35 °C, and is typical from 0 to 15 °C. Maximum power over the 35 to 55 °C range typically degrades less than 2 dB unless otherwise stated.
- 2. With 1/0 modulation on, maximum power specification is typical. With external inputs enabled, $\sqrt{(l^2 + Q^2)} > 0.2 V_{rms}$.
- 3. With harmonic filters switched off. With filters on, maximum output power is reduced 3 dB for frequencies below 2 GHz.
- 4. With I/Q modulation on, maximum power specification is typically reduced 3 dB.
- Maximum power over the 35 to 55 °C range typically degrades less than 4 dB. With I/Q modulation on, maximum power specification is typically reduced 5 dB.
- The step attenuator provides coarse power attenuation to achieve low power levels. Fine power level adjustment is provided by the ALC (Automatic Level Control) within the attenuator hold range.
- 7. To within 0.1 dB of final amplitude within one attenuator range. Add 10 to 50 ms when using power search.

B)			
> +10 dBm	+10 to –10 dBm	—10 to —70 dBm	–70 to –90 dBm
±0.6	±0.6	±0.7	±0.8
±0.8	±0.8	±0.9	±1.0
±1.0	±0.9	±1.0	±1.7
±1.0	±0.9	±1.5	±2.0
with I/Q mod	ulation (With PRBS	modulated data) (relative to CW) ²
QAM or QPSK formats ³		± 0.2 dB	
Constant-amplitude formats (FSK, GMSK, etc)		± 0.2 dB	
With ALC off: ⁴		± 0.2 dB (typ)	
	> +10 dBm ±0.6 ±0.8 ±1.0 ±1.0 with I/Q mode	> +10 dBm +10 to -10 dBm ±0.6 ±0.6 ±0.8 ±0.8 ±1.0 ±0.9 ±1.0 ±0.9 with I/Q modulation (With PRBS ats ³	> +10 dBm +10 to -10 dBm -10 to -70 dBm ± 0.6 ± 0.7 ± 0.8 ± 0.9 ± 1.0 ± 0.2 dB e formats (FSK, GMSK, etc) ± 0.2 dB

Level accuracy (measured)



Resolution	0.01 dB
Temperature stability	0.01 dB/ °C (typ)⁵
User flatness correction	
Number of points	2 to 1601 points/table
Number of tables	Up to 10,000, memory limited
Path loss	Arbitrary, within attenuator range
Entry modes	Remote power meter ⁶ , remote bus, manual
	(user edit/view)
Output impedance	50 Ω (nom)
SWR (internally leveled)	
250 kHz to 2 GHz	< 1.4:1 (typ)
> 2 GHz to 20 GHz	< 1.6:1 (typ)
> 20 GHz	< 1.8:1 (typ)
Leveling modes	Internal leveling, external detector leveling,
	millimeter source module, ALC off

Specifications apply in CW and list/step sweep modes over the 15 to 35 °C temperature range, with attenuator hold off (normal operating mode). Degradation outside this range, for ALC power levels > -5 dBm, is typically < 0.3 dB. In ramp sweep mode (with Option 007), specifications are typical. For instruments with Type-N connectors (Option 1ED), specifications are degraded typically 0.2 dB above 18 GHz. Specifications do not apply above the maximum specified power.

^{2.} If external inputs are used, specification applies with input level $\sqrt{(l^2 + Q^2)} = 0.3 V_{rms}$ and l/Q modulator attenuation is internally optimized based on input levels.

^{3.} Measured with symbol rate > 10 kHz and power \leq 0 dBm.

^{4.} Relative to ALC on, after power search is executed. When applying external I/Q signals with ALC off, output level will vary directly with I/Q input level.

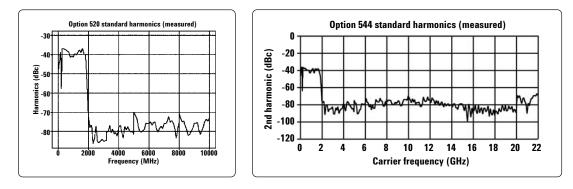
^{5.} Options 532 and 544: 0.02 dB/°C (typ) above 2 GHz.

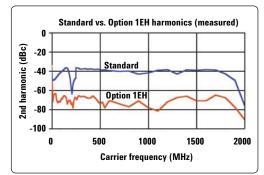
^{6.} Compatible with Agilent EPM Series (E4418B and E4419B) power meters.

External detector leveling	
Range	–0.2 mV to –0.5 V (nom) (–36 dBm to +4 dBm using
	Agilent 33330D/E detector)
Bandwidth	Selectable 0.1 to 100 kHz (nom) (Note: not intended
	for pulsed operation)
Maximum reverse power	1/2 Watt, 0 V _{DC}

Spectral purity

Harmonics¹ (at +10 dBm or maximum specified output power, whichever is lower) < 10 MHz -28 dBc (typical below 1 MHz) 10 MHz to 2 GHz −28 dBc² 10 MHz to 2 GHz (with Option 1EH filters on) -55 dBc³ > 2 GHz to 20 GHz –55 dBc > 20 GHz to 44 GHz –45 dBc Harmonics (measured)





- Typical below 250 MHz if Option 1EH is installed and filters are off.
- 3. In ramp sweep mode (Option 007), harmonics are -28 dBc below 250 MHz.

Specifications are typical for harmonics beyond specified frequency range. 1. 2.

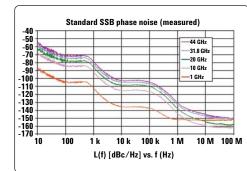
Sub-harmonics ¹		/At 10 dBm		fied output
Sub-narmonics		power, which	or maximum specit	ned output
250 kHz to 10 GHz		None	ever is lower)	
> 10 GHz to 20 GHz		< -60 dBc		
		< 50 dBc		
> 20 GHz to 40 GHz				
> 40 GHz to 44 GHz Non-harmonics ²		< -45 dBc	Pm or movimum o	nonified output
Non-narmonics			Bm or maximum s ever is lower, for o	
				IISELS > 3 KHZ
Eroquonov			h Option UNR]) Typical	
Frequency 250 kHz to 250 MHz		Sрес —65	<i>'</i> · ·) kHz offsets
> 250 KHz to 250 MHz			-88	J KHZ UIISELS
> 1 to 2 GHz		_00 _74	82	
> 1 to 2 GHz > 2 to 3.2 GHz			82 76	
> 3.2 to 10 GHz		62	-76 -70	
> 10 to 20 GHz			_70 _64	
> 20 to 28.5 GHz		50 52	64 60	
> 28.5 to 44 GHz	0			
SSB phase noise (CV Frequency	v)	20 kHz	arrier (dBc/Hz)	`
250 kHz to 250 MHz ³		-130	20 kHz (typ –134)
$> 250 \text{ kHz} 10 250 \text{ MHz}^3$		-130 -134		
			-138	
> 500 MHz to 1 GHz ³		-130	-134	
> 1 to 2 GHz ³		-124	-128	
> 2 to 3.2 GHz > 3.2 to 10 GHz		-120	-124	
> 10 to 20 GHz		-110 -104	–113 –108	
> 20 to 28.5 GHz		-104 -100	-108 -104	
> 20 to 20.5 GHz		-96	-104 -100	
Option UNR: Enhance	d SSB nhaca		-100	
Option ONN. Enhance	a sob pliase		arrier (dBc/Hz)	
Frequency	100 Hz	1 kHz	10 kHz	100 kHz
requency	spec (typ)	spec (typ)	spec (typ)	spec (typ)
250 kHz to 250 MHz ³	–94 (–115)	–110 (–123)	–128 (–132)	–130 (–133)
> 250 to 500 MHz ³	-100 (-110)	-124 (-130)	-132 (-136)	-136 (-141)
> 500 MHz to 1 GHz ³	. ,	-118 (-126)	-130 (-135)	-130 (-135)
> 1 to 2 GHz ³	-94 (-104) -88 (-98)	-112 (-120)	-124 (-129)	-124 (-129)
> 2 to 3.2 GHz	-84 (-94)	-108 (-116)	-120 (-125)	-124 (-125) -120 (-125)
> 3.2 to 10 GHz	-04 (-34) -74 (-84)	-98 (-106)	-110 (-115)	-110 (-115)
> 10 to 20 GHz	-68 (-78)	-92 (-100)	-104 (-107)	-104 (-109)
> 20 to 28.5 GHz	-64 (-74)	-88 (-96)	-100 (-103)	-100 (-105)
> 28.5 to 44 GHz	-60 (-70)	-84 (-92)	-96 (-99)	-96 (-101)
Residual FM	,,,,	0. (02)		
(rms, 50 Hz to 15 kHz	bandwidth)			
CW mode	20.10000001	< N x 8 Hz (typ)		
Option UNR		$< N \times 4 Hz (typ)$		
Ramp sweep mode		$< N \times 1 \text{ kHz (typ)}$		
Broadband noise		(CW mode at +10 c	Bm or maximum s	specified output
		power, whichever is		•
> 2.4 to 20 GHz		< -148 dBc/Hz (ty		
> 20 GHz		< -141 dBc/Hz (ty	• •	

1. Sub-harmonics are defined as Carrier Freq / N). Specifications are typical for sub-harmonics beyond specified frequency range.

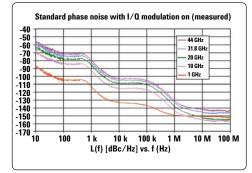
 Performance is typical for spurs at frequencies above the maximum operating frequency of the instrument. Specifications apply for CW mode, without modulation. In ramp sweep mode (Option 007), performance is typical for offsets > 1 MHz.

3. Measured at +10 dBm or maximum specified output power, whichever is less.

Measured phase noise with an Agilent E5500 phase noise measurement system and plotted without spurs

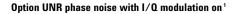


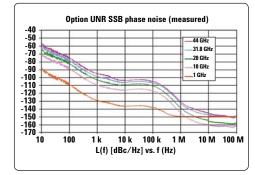
Standard phase noise with I/Q modulation on ¹

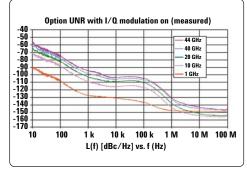


Option UNR phase noise

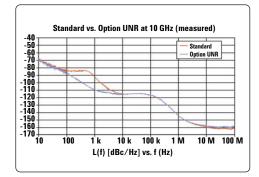
Standard phase noise



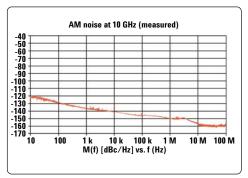












1. External I/Q input level $\sqrt{(I^2 + Q^2)} = 250$ mVrms, I/Q modulator attenuator set to auto.

Measured rms	jitter:1			
Standard				
Carrier	SONET/SDH	RMS jitter	Unit intervals	Time
frequency	data rates	bandwidth	(µUI)	(fs)
155 MHz	155 MB/s	100 Hz to 1.5 MHz	27	174
622 MHz	622 MB/s	1 kHz to 5 MHz	25	40
2.488 GHz	2488 MB/s	5 kHz to 20 MHz	77	31
9.953 GHz	9953 MB/s	10 kHz to 80 MHz	206	21
39.812 GHz	39812 MB/s	40 kHz to 320 MHz	704	18
Option UNR				
Carrier	SONET/SDH	RMS jitter	Unit intervals	Time
frequency	data rates	bandwidth	(µUI)	(fs)
155 MHz	155 MB/s	100 Hz to 1.5 MHz	29	186
622 MHz	622 MB/s	1 kHz to 5 MHz	25	40
2.488 GHz	2488 MB/s	5 kHz to 20 MHz	82	33
9.953 GHz	9953 MB/s	10 kHz to 80 MHz	212	21
39.812 GHz	39812 MB/s	40 kHz to 320 MHz	683	17

Frequency modulation

(Option UNT)

Maximum deviation ²	Frequency	Maximum deviation
	250 kHz to 250 MHz	2 MHz
	> 250 to 500 MHz	1 MHz
	> 500 MHz to 1 GHz	2 MHz
	> 1 GHz to 2 GHz	4 MHz
	> 2 GHz to 3.2 GHz	8 MHz
	> 3.2 GHz to 10 GHz	16 MHz
	> 10 GHz to 20 GHz	32 MHz
	> 20 GHz to 28.5 GHz	48 MHz
	> 28.5 GHz to 44 GHz	80 MHz
Resolution	0.1% of deviation or 1 H	Hz, whichever is greater
Deviation accuracy	$< \pm 3.5\%$ of FM deviation	on + 20 Hz
	(1 kHz rate, deviations	< N x 800 kHz)
Modulation frequency respon	1 se ³ (at 100 kHz deviation)	
Path [coupling]		
	1 dB bandwidth	3 dB bandwidth (typ)
FM path 1 [DC]	DC to 100 kHz	DC to 10 MHz
FM path 2 [DC]	DC to 100 kHz	DC to 1 MHz
FM path 1 [AC]	20 Hz to 100 kHz	5 Hz to 10 MHz
FM path 2 [AC]	20 Hz to 100 kHz	5 Hz to 1 MHz
DC FM⁴ carrier offset	±0.1% of set deviation	1 /
Distortion	< 1% (1 kHz rate, devia	1
Sensitivity	±1 V _{peak} for indicated o	
Paths		med internally for composit
		n may be switched to any
		sources: Ext1, Ext2, internal
	•	h is limited to a maximum
	rate of 1 MHz. The FM2	
	deviation less than FM	1.

4. user calibration.

Calculated from phase noise performance in CW mode only at +10 dBm. For other frequencies, data rate, or bandwidths, please contact your sales representative. 1.

^{2.} Through any combination of path1, path2, or path1 + path2.

Specifications apply in CW and list/step sweep modes. During ramp sweep operation (Option 007), 3 dB bandwidth is typically 50 kHz to 10 MHz (FM1 path), and 50 kHz to 1 MHz (FM2 path). At the calibrated deviation and carrier frequency, within 5 °C of ambient temperature at time of 3.

Phase modulation

(Option UNT)

Maximum deviation ¹	Frequency	Normal BW mode	High BW mode
	250 kHz to 250 MHz	20 rad	2 rad
	> 250 to 500 MHz	10 rad	1 rad
	> 500 MHz to 1 GHz	20 rad	2 rad
	> 1 GHz to 2 GHz	40 rad	4 rad
	> 2 GHz to 3.2 GHz	80 rad	8 rad
	> 3.2 GHz to 10 GHz	160 rad	16 rad
	> 10 GHz to 20 GHz	320 rad	32 rad
	> 20 GHz to 28.5 GHz	480 rad	48 rad
	> 28.5 GHz to 44 GHz	800 rad	80 rad
Resolution	0.1% of set deviati	on	
Deviation accuracy	< ±5% of deviation	+ 0.01 radians (1 kHz rate	e, normal BW mode
Modulation frequency	response ²		
	Normal BW mode	High BV	V mode
Rates (3 dB BW)	DC to 100 kHz	DC to 1N	ИHz (typ)³
Distortion	< 1 % (1 kHz rate,	Total Harmonic Distort	ion (THD),
	dev < N x 80 rad, r	normal BW mode)	
Sensitivity	±1 V _{peak} for indica	ted deviation	
Paths	Φ M1 and Φ M2 ar	e summed internally fo	or composite
	modulation. Either	path may be switched	to any one of
	the modulation so	urces: Ext1, Ext2, interi	nal1, internal2.
	The Φ M2 path mu	ist be set to a deviatior	h less than Φ M1.

Amplitude modulation⁴

(Option UNT) (typ)

Depth		
	Linear mode	Exponential (log) mode (downward modulation only)
Maximum		
ALC on	> 90%	> 20 dB
ALC off or Deep AM on⁵	> 95%	> 40 dB ⁶
Settable	0 to 100 %	0 to 40 dB
Resolution	0.1%	0.01 dB
Accuracy (1 kHz rate)	< ±(6 % of setting + 1 %)	$< \pm (2\% \text{ of setting} + 0.2 \text{ dB})$
Ext sensitivity	±1 V _{peak} for indicated depth	-1 V _{peak} for indicated depth
Rates (3 dB bandwidth, 30%	depth)	·
DC coupled	0 to 100 kHz	
AC coupled	10 Hz to 100 kHz (useable to 1	l MHz)
Distortion (1 kHz rate, linear	mode, Total Harmonic Distortior	n (THD))
30% AM	< 1.5%	
60% AM	< 2 %	
Paths	AM1 and AM2 are summed in	ternally for composite
	modulation. Either path may be modulation sources: Ext1, Ext2	,

1. Through any combination of path1, path2, or path1 + path2.

 Specifications apply in CW and list/step sweep modes. During ramp sweep operation (Option 007), 3 dB bandwidth is typically 50 kHz to 1 MHz (high BW mode).

3. Path 1 is useable to 4 MHz for external inputs less than 0.3 V_{peak}.

^{4.} AM specifications are typical. For carrier frequencies below 2 MHz, AM is useable but not specified. Unless otherwise stated, specifications apply with ALC on, Deep AM off, and envelope peaks within ALC operating range (-15 dBm to maximum specified power, excluding step attenuator setting).

^{5.} For reduced distortion at high modulation depths, either Level Hold mode (ALC off with Power Search) or Deep AM mode should be used. With ALC on in Deep AM mode, waveform peaks are controlled by ALC system, and the lower portion of the waveform (below –10 dBm nominal ALC level) is subject to sample-and-hold drift of approximately 0.25 dB/second.

^{6.} To achieve > 40 dB depth, less than -1 V external input may be required.

External modulation inputs (Ext1 & Ext2) (Option UNT)

Internal modulation source (Option UNT)

Modulation types	AM, FM, and ΦM
Input impedance	50 or 600 Ω (nom), switched
High/low indicator	
(100 Hz to 10 MHz BW,	Activated when input level error exceeds 3%
ac coupled inputs only)	(nom)

Dual function generators provide two independent signals (internal1 and internal2) for use with AM, FM, ΦM , or LF Out.

Waveforms	Sine, square, positive ramp, negative ramp,
	triangle, Gaussian noise, uniform noise, swept
	sine, dual sine¹
Rate range	
Sine	0.5 Hz to 1 MHz
Square, ramp, triangle	0.5 Hz to 100 kHz
Resolution	0.5 Hz
Accuracy	Same as timebase
LF out	
Output	Internal1 or internal2. Also provides monitoring
	of internal1 or internal2 when used for AM, FM,
	or Φ M.
Amplitude	0 to 3 V _{peak} , into 50 Ω (nom)
Output impedance	50 Ω (nom)
Swept sine mode: (frequency,	phase continuous)
Operating modes	Triggered or continuous sweeps
Frequency range	1 Hz to 1 MHz
Sweep rate	0.5 Hz to 100 kHz sweep/s, equivalent to sweep
	times 10 µs to 2 s
Resolution	0.5 Hz (0.5 sweep/s)

Wideband AM

Rate (typical 1 dB bandwidth)

ALC on	1 kHz to 80 MHz	
ALC off	DC to 80 MHz	
External I input		
Sensitivity	0.5 V = 100%	
Input impedance	50 Ω (nom)	

Pulse modulation 1, 2

(Option UNU)

	500 MHz to 3.2 GHz	Above 3.2 GHz
On/Off ratio	80 dB (typ)	80 dB
Rise/Fall times (Tr, Tf)	100 ns (typ)	6 ns (typ)
Minimum pulse width		
Internally leveled	2 µs	1 μs
Level hold (ALC off with power search)	0.5 µs	0.15 μs
Repetition frequency		
Internally leveled	10 Hz to 250 kHz	10 Hz to 500 kHz
Level hold (ALC off with power search)	DC to 1 MHz	DC to 3 MHz
Level accuracy (relative to CW)		
Internally leveled	±0.5 dB	±0.5 dB
Level hold (ALC off with power search)	±0.5 dB (typ)	±0.5 dB (typ)
Width compression		<u> </u>
(RF width relative to video out)	±50 ns (typ)	±5 ns (typ)
Video feed-through ³	< 200 mv (typ)	< 2 mv (typ)
Video delay (Ext input to video)	50 ns (nom)	50 ns (nom)
RF delay (video to RF output)	270 ns (nom)	35 ns (nom)
Pulse overshoot	< 10% (typ)	< 10% (typ)
Input level	+1 V _{peak} = RF On	+1 V _{peak} = RF On
Input impedance	50 Ω (nom)	50 Ω (nom)

Narrow pulse modulation^{1,2}

(Option UNW)

	10 MHz to 3.2 GHz	Above 3.2 GHz
On/Off ratio	80 dB	80 dB
Rise/Fall times (Tr, Tf)	10 ns (8 ns typ)	10 ns (6 ns typ)
Minimum pulse width		
Internally leveled:	1 µs	1 µs
Level hold (ALC off with power search):	20 ns	20 ns
Repetition frequency		
Internally leveled:	10 Hz to 500 kHz	10 Hz to 500 kHz
Level hold (ALC off with power search):	DC to 5 MHz	DC to 10 MHz
Level accuracy (relative to CW)		
Internally leveled	±0.5 dB	±0.5 dB (0.15 dB typ)
Level hold (ALC off with power search):	±1.3 dB (typ)	±0.5 dB (typ)

^{1.} With ALC off, specifications apply after the execution of power search. Specifications apply with Atten Hold Off (default mode), or ALC level between –5 and +10 dBm or maximum specified power, whichever is lower .

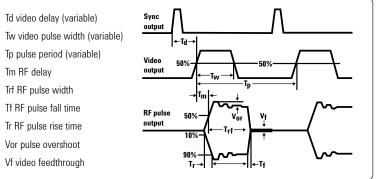
^{2.} Power search is a calibration routine that improves level accuracy with ALC off. The instrument microprocessor momentarily closes the ALC loop to find the modulator drive setting necessary to make the quiescent RF level equal to an entered value, then opens the ALC loop while maintaining that modulator drive setting. When executing power search, RF power will be present for typically 10-50 ms; the step attenuator can be set to automatically switch to maximum attenuation to protect sensitive devices. Power search can be configured to operate either automatically or manually at the carrier frequency, or over a user-definable frequency range.

^{3.} With attenuator in 0 dB position. Video feed-through decreases with attenuator setting.

	10 MHz to 3.2 GHz	Above 3.2 GHz
Width compression		
(RF width relative to video out)	±5 ns (typ)	±5 ns (typ)
Video feed-through ¹	< 125 mv (typ)	< 2 mv (typ)
Video delay (Ext input to video)	50 ns (nom)	50 ns (nom)
RF delay (video to RF output)	45 ns (nom)	35 ns (nom)
Pulse overshoot	< 15% (typ)	< 10% (typ)
Input level	+1 V _{peak} = RF On	+1 V _{peak} = RF On
Input impedance	50 Ω (nom)	50 Ω (nom)

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les require an external trigger source. 2 s
$f_{\mu\nu}$ $g_{\mu\nu}$ g
n frequency: 0.024 Hz to 14.28 MHz)
2 s
2 s with ±10 ns jitter
th, delay, and PRI)
_



All modulation types (FM, AM, Φ M, pulse. and I/Q) may be simultaneously enabled except: FM with Φ M, linear AM with exponential AM, and wideband AM with I/Q. AM, FM, and ΦM can sum simultaneous inputs from any two sources (Ext1, Ext2, internal1, or internal2). Any given source (Ext1, Ext2, internal1, or internal2) may be routed to only one activated modulation type.

1. With attenuator in 0 dB position. Video feed-through decreases with attenuator setting.

Internal pulse generator

Simultaneous modulation

(Option UNU or UNW)

Vector modulation¹

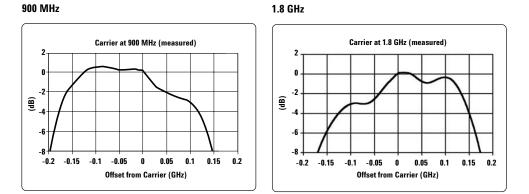
External I/Q inputs

Input range²

Flatness

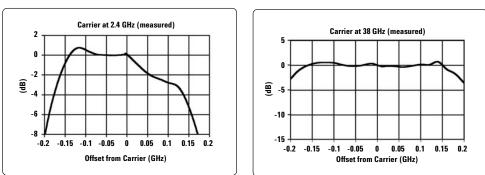
Input impedance switched 50 or 600 Ω (nom) Minimum 0.1 V_{rms} , maximum $1V_{\text{peak}}$ \pm 1 dB within \pm 40 MHz of carrier (with ALC off) (typ)

I/Q frequency response³ (measured)





38 GHz



RF path filters	Carrier frequency	Nominal filter cutoff frequenies
	≤ 250 MHz	300 MHz low-pass filter
	> 250 to 396 MHz	220 to 420 MHz bandpass filter
	> 396 to 628 MHz	350 to 650 MHz bandpass filter
	> 628 to 1000 MHz	1040 MHz low-pass filter
	> 1.0 to 1.5 GHz	1.6 GHz low-pass filter

Sine wave response, measured with input level = 100 mVrms on one channel, and ALC off. For 3. carrier frequencies below 1.5 GHz, modulation frequency response within \pm 150 MHz of carrier may be limited by RF chain filtering.

With Option 007, vector modulation is not useable in ramp sweep mode. With Option 1EH, 1. specifications apply with filters off.

For optimum signal quality, the I and Q inputs should be 0.7 V_{peak} , with $\sqrt{(l^2 + Q^2)} + 150 \text{ mV}_{rms}$. Different RMS levels are accommodated by adjusting the internal I/Q modulator attenuator, 2. which may be either manually or automatically set. The minimum input level required to maintain RF level accuracy is $\sqrt{(I^2 + Q^2)} = 0.1 V_{rms}$.

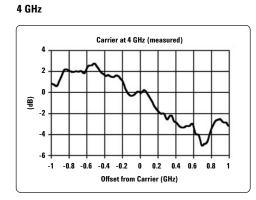
I/Q adjustments	
I & Q offsets	External inputs (600 Ω): ± 5 Volts
	External inputs (50 Ω): ± 50 %
	Internal baseband generator: ± 50 %
I/Q attenuation	0 to 40 dB
I/Q gain balance	± 4 dB
I/Q quadrature skew	± 10 ° range (typ)
Low pass filter	Selectable 40 MHz or through path
I/Q baseband outputs	
Differential	I, T, Q, Q
Single ended	I, Q
Frequency range	DC to 40 MHz
Output voltage into 50 W	1.5 V _{peak-to-peak} (typ)
DC offset adjustments	± 3 V
DC offset resolution	1 mV
Low pass filter	Selectable 40 MHz or through path

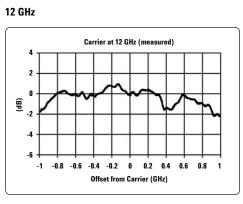
Wideband external $\rm I/\rm Q$ inputs

(Option 015)

RF output frequency range	3.2 to 44 GHz
Input	
Input (baseband) frequency range	DC to 1.0 GHz (nom) ¹
Input impedance	50 Ω (nom)
Recommended input level	0 dBm (nom)
Maximum input voltage	±1 V _{DC}
I/Q offset adjustments	±50%
I/Q quadrature skew	±10 degrees (nom)
1/0 fraguency response (massured)	

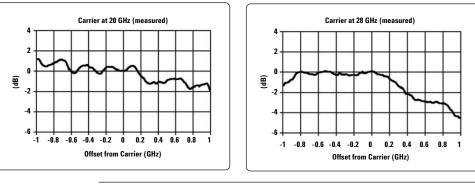
I/Q frequency response (measured)



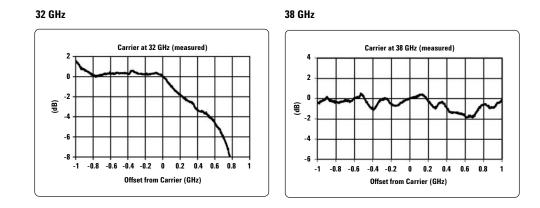


20 GHz





1. Modulation frequency response within ±1 GHz of the carrier frequency may be limited by the RF chain cutoff frequencies.



RF path filters¹ Carrier frequency > 3.2 to 5 GHz

/	
> 3.2 to 5 GHz	5.5 GHz low-pass filter
> 5 to 8 GHz	8.9 GHz low-pass filter
> 8 to 12.8 GHz	13.9 GHz low-pass filter
> 12.8 to 20 GHz	22.5 GHz low-pass filter
> 20 to 24 GHz	19.6 to 24.5 GHz band-pass filter
> 24 to 28.5 GHz	23.5 to 29.0 GHz band-pass filter
> 28.5 to 32 GHz	28.0 to 32.5 GHz band-pass filter
> 32 to 36 GHz	31.7 to 36.5 GHz band-pass filter
> 36 to 40 GHz	35.5 to 40.4 GHz band-pass filter
> 40 to 44 GHz	39.5 to 44.3 GHz band-pass filter

Internal baseband generator: arbitrary waveform mode (Options 601 and 602)

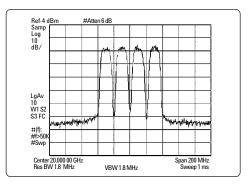
Channels	2 [l and Q]
Resolution	16 bits [1/65,536]
Baseband waveform memory	
Length (playback)	
Option 601	8 megasamples (MSa/channel)
Option 602	64 megasamples (MSa/channel)
Length (non-volatile storage) 005)	1.2 gigasamples (GSa) on 6 GB hard drive (Option
Waveform segments	
Segment length	60 samples to 8 or 64 MSa
Maximum number of segments	1,024 (Option 601)
	8,192 (Option 602)
Minimum memory allocation	256 samples or 1 kbyte blocks
Waveform sequences	
Sequencing	Continuously repeating
Maximum number of sequences	16,384
Maximum segments/sequence	32,768
Maximum segment repetitions	65,536
Clock	
Sample rate	1 Hz to 100 MHz
Resolution	0.001 Hz
Accuracy	Same as timebase +2 ⁻⁴² [in non-integer applications]
Reconstruction filter: [fixed]	50 MHz [used for all symbol rates]

Nominal filter cutoff frequencies

1. Modulation frequency response within ±1 GHz of the carrier frequency may be limited by the RF chain cutoff frequencies.

Baseband spectral purity	
[full scale sinewave]	
Harmonic distortion	100 kHz to 2 MHz: < –65 dBc (typ)
Phase noise	< -127 dBc/Hz (typ) (baseband output of 10 MHz
INA menterumente	sinewave at 20 kHz offset)
IM performance	< -74 dB (typ)
Triggers Turner	Continuous simple anted as much shares
Types	Continuous, single, gated, segment advance
Source	Trigger key, external, remote [LAN, GPIB, RS-232]
External polarity	Negative, positive
External delay time	10 ns to 40 s plus latency
External delay resolution	10 ns
Markers	
(Markers are defined in a segme	ent during the waveform generation process, or from the
PSG front panel. A marker can a	also be tied to the RF blanking feature of the PSG.)
Marker polarity	Negative, positive
Number of markers	4
Multicarrier	
Number of carriers	Up to 100 (limited by a maximum bandwidth of 80 MH:
	depending on symbol rate and modulation type)
Frequency offset (per carrier)	-40 MHz to +40 MHz
Power offset (per carrier)	0 dB to -40 dB
Modulation	Types
PSK	BPSK, QPSK, OQPSK, $\pi/4$ DQPSK, 8PSK, 16PSK, D8PSK
QAM	4, 16, 32, 64, 128, 256
FSK	Selectable: 2, 4, 8, 16
MSK	
	Random ONLY
Data	

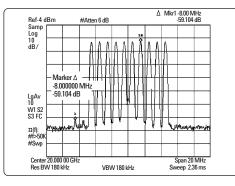
4 Carriers with 64 QAM at 10 Msym/s with 20 MHz spacing



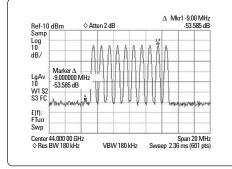
Multitone

Number of tones Frequency spacing Phase (per tone) Power offset (per tone) 2 to 64, with selectable on/off state per tone 100 Hz to 80 MHz Fixed or random 0 to -40 dB

20 GHz multitone (measured)

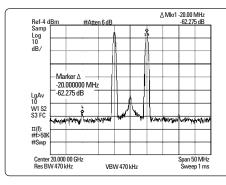


44 GHz multitone (measured)

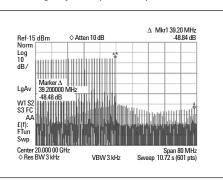


Two-tone Frequency spacing Alignment IM distortion 1 250 kHz to 3.2 GHz > 3.2 GHz to 20 GHz > 20 to 40 GHz > 40 to 44 GHz

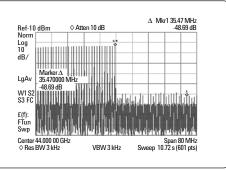
20 GHz two tone (measured)



20 GHz image rejection (measured)



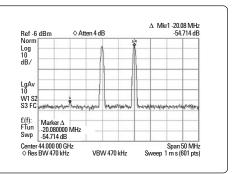
44 GHz image rejection (measured)



100 Hz to 80 MHz) Left, centered, or right

< -45 dBc (typ) < -55 dBc (typ) < -50 dBc (typ) < -45 dBc (typ)

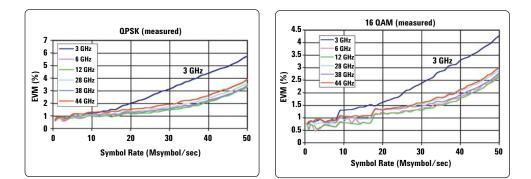
44 GHz two tone (measured)



1. RF power < 0 dBm (Option 520) or < -3 dBm (Option 532, 544). When external inputs are used, vector accuracy is equivalent to internal performance after system calibration.

Internal baseband generator: real-time mode (Option 601 and 602)

Basic modulation types (cust	om format)
PSK	BPSK, QPSK, OQPSK, $\pi/4$ DQPSK, 8PSK,
	16PSK, D8PSK
MSK	User-defined phase offset from 0 to 100 $^{\circ}$
QAM	4, 16, 32, 64, 128, 256
FSK	Selectable: 2, 4, 8, 16 level symmetric, C4FM
	User defined: Up to 16 custom deviation levels
	Deviation resolution: 0.1 Hz
	Symbol rate Maximum deviation
	< 5 MHz 4 times symbol rate
	5 MHz to 50 MHz 20 MHz
User-defined I/Q	Custom map of 256 unique values
Vector accuracy ¹	Formats: BPSK, QPSK, 16-256 QAM (α = 0.3, ro
	Nyquist filter, symbol rate 4 Msym/s)
EVM (% RMS)	
≤ 20 GHz	< 1.2%, < 0.8% (typ)
> 20 to 32 GHz	< 1.3% < 0.9% (typ)
> 32 to 44 GHz	< 1.4% < 0.9% (typ)
Origin offset	
250 kHz to 3.2 GHz	–45 dBc (typ)
3.2 to 44 GHz	–50 dBc (typ)
EVM (measured)	



FIR filter	
Selectable	Nyquist, root Nyquist, Gaussian, rectangular $\alpha{:}~0$ to 1, $B_b T{:}~0.1$ to 1
Custom FIR	16-bit resolution, up to 64 symbols long, automatically resampled to 1024 coefficients (maximum > 32 to 64 symbol filter: symbol rate ≤ 12.5 MHz > 16 to 32 symbol filter: symbol rate ≤ 25 MHz Internal filters switch to 16 tap when symbol rate is between 25 and 50 MHz
Symbol rate	
For external serial data:	Adjustable from 1000 symbols/sec to a maximum symbol rate of 50 Mbits/sec ÷ (#bits/symbol)
For internally generated data:	Adjustable from 1000 symbols/sec to 50 Msymbols/second and a maximum of 8 bits per symbol. Modulation quality may be degraded at high symbol rates.

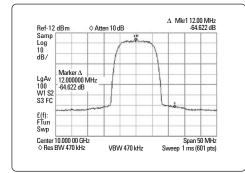
Measured with Agilent 89441A vector signal analyzer. Valid after executing I/Q calibration, and instrument is maintained within ±5 °C of calibration temperature. RF power < 0 dBm (Option 520) or < -3 dBm (Option 532, 544). When external inputs are used, vector accuracy is equivalent to internal performance, after system calibration.

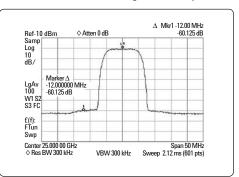
Baseband reference frequency	Data clock can be phase locked to an external reference
Input	ECL, CMOS, TTL compatible, 50 Ω AC coupled
Frame trigger delay control	
Range	0 to 1,048,575 bits
Resolution	1 bit
Data types	
Internally generated data	
Pseudo-random patterns	PN9, PN11, PN15, PN20, PN23
Repeating sequence	Any 4-bit sequence
	Other fixed patterns
Direct-pattern RAM [PRAM]	
Max size	8 MB (Option 601)
	64 MB (Option 602)
	(each bit uses an entire sample space)
Use	Non-standard framing
User file	
Max size	800 KB (Option 601)
	6.4 MB (Option 602)
Use	Continuous modulation or internally generated
TDMA standard	
Externally generated data	
Туре	Serial data
Inputs	Data, data (bit) clock, symbol sync
	Accepts data rates ±5% of specified data rate
Internal burst shape control	· · · · · · · · · · · · · · · · · · ·
Varies with standards and bit rates	3
Rise/Fall time range	Up to 30 bits
Rise/Fall delay range	0 to 63.5 bits

Spectral re-growth (measured)

10 GHz carrier with 16 QAM signal at 10 Msym/s

25 GHz carrier with 16 QAM signal at 10 $\rm Msym/s$





Remote programming

General specifications

Interfaces	GPIB (IEEE-488.2,1987) with listen and talk, RS-232,
A	and 10BaseT LAN interface
Control languages	SCPI version 1997.0. Also will emulate most applicable
	Agilent 836xxB, Agilent 837xxB, 8662/3A and Agilent
	8340/41B commands, providing general compatibility
	with ATE systems which include these signal generators.
IEEE-488 functions	SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT0, C0, E2
ISO compliant	This family of signal generators is manufactured in an
	ISO-9001 registered facility in concurrence with
	Agilent Technologies' commitment to quality.
Agilent IO Libraries	Agilent's IO Libraries Suite ships with the E8267D to help
	you quickly establish an error-free connection between you
	PC and instruments – regardless of the vendor. It provides
	robust instrument control and works with the software
	development environment you choose.
Power requirements	90 to 267 Vac 50 to 60 Hz, (automatically selected);
	< 400 W typ 650 W maximum
Operating temperature range	0 to 55 °C1
Storage temperature range ²	-40 to 70 °C
With Option 005	–4 ° to 65 °C, gradient less than 20 °C/hour
Shock and vibration	
Operating random vibration	5 to 500 Hz, 0.21 g rms
Survival swept sine vibration	5 to 500 Hz, 0.5 g
Survival random vibration	5 to 500 Hz, 2.09 g rms
	Functional shock (half-sine, 30 g, 11 ms) and bench drop test
	Meets the requirements of MIL-PRF-28800F for class 3 equipment
EMC	Meets the conducted and radiated interference and
	immunity requirements of IEC/EN 61326-1. Meets radiated
	emission requirements of CISPR Pub 11/1997 Group 1 class A.
Storage registers	Memory is shared by instrument states, user data files,
0 0	sweep list files, and waveform sequences. Depending
	on the number and size of these files, up to 800 storage
	registers and 10 register sequences are available.
Security	Display blanking
•	Memory clearing functions (See Application Note
	"Security of Agilent Singal Generators Issues and Solutions"
	Literature Number, 5989-1091EN)
Compatibility	Agilent 83550 Series Millimeter Heads and OML
	millimeter source modules
	Agilent 8757D scalar network analyzers
	Agilent EPM Series power meters
Self-test	Internal diagnostic routine tests most modules (including
	microcircuits) in a preset condition. For each module,
	if its node voltages are within acceptable limits, then
	the module "passes" the test.
Weight	< 25 kg (54 lb.) net, < 33 kg (74 lb.) shipping
Dimensions	178 mm H x 426 mm W x 515 mm D
	(7" H x 16.8" W x 20.3" D in.)

Save and recall of user files and instrument states from Option 005 hard drive is guaranteed only over the range 0 to 40 °C.
 Storage below -20 °C instrument states may be lost.

Input/Output Descriptions

Front panel connectors

(All connectors are BNC female unless otherwise noted.)¹

RF output	Output impedance 50 Ω (nom)
Option 520	Precision APC-3.5 male or precision Type-N female
	with Option 1ED
Options 532 and 544	Precision 2.4 mm male; plus 2.4(f) - 2.4(f) mm and
	2.4(f) - 2.9(f) mm adaptors
ALC input	Used for negative external detector leveling
	Nominal input impedance 120 k Ω , damage level ±15 V.
LF output	Outputs the internally generated LF source. Nominal output
Li output	impedance 50 Ω .
External input 1	Drives either AM, FM, or Φ M. Nominal input impedance 50
	or 600 Ω , damage levels are 5 V _{rms} and 10 V _{peak} .
External input 2	Drives either AM, FM, or Φ M. Nominal input impedance 50
External input 2	or 600 Ω , damage levels are 5 V _{rms} and 10 V _{peak} .
Pulse/trigger gate input	Accepts input signal for external fast pulse modulation.
i uise/ tilgger gate input	Also accepts external trigger pulse input for internal pulse
	modulation. Nominal impedance 50 Ω . Damage levels are
	5 $V_{\rm rms}$ and 10 $V_{\rm peak}$.
Pulse video out	Outputs a signal that follows the RF output in all pulse modes.
	TTL-level compatible, nominal source impedance 50 Ω .
Pulse sync out	Outputs a synchronizing pulse, nominally 50 ns width,
i uise syne out	during internal and triggered pulse modulation. TTL-level
	compatible, nominal source impedance 50 Ω .
Data clock input	Accepts a data clock signal to synchronize serial data for
Data clock input	use with internal baseband generator (Option 601 or 602).
	Maximum rate 50 MHz. Damage levels are $> +5.5$ V and < -0.5 V.
Data input	Accepts serial data for use with internal baseband generator
Data input	(Option 601 or 602). Maximum rate 50 Mb/s. Data must be
	valid on the falling edges of data clock (normal mode) or
	the symbol sync (symbol mode). Damage levels are $> +5.5$ V
	and < -0.5 V.
l input	Accepts an "I" input either for I/Q modulation or for
i input	wideband AM. Nominal input impedance 50 or 600 Ω .
	Damage levels are 1 V _{rms} and 5 V _{peak} .
Q input	Accepts a "Q" input for I/Q modulation. Nominal input
a mpat	impedance 50 or 600 Ω . Damage levels are 1 V _{rms} and 5 V _{peak} .
Symbol sync input	Accepts symbol sync signal for use with internal baseband
oymool sync mput	generator (Option 601 or 602). Symbol sync might occur once
	per symbol or be a single, one bit wide pulse to synchronize
	the first bit of the first symbol. Maximum rate 50 MHz.
	Damage levels are $> +5.5$ V and < -0.5 V.

 Digital inputs and outputs are 3.3 V CMOS unless indicated. Otherwise, inputs will accept 5 V CMOS, 3 V CMOS or TTL voltage levels.

Rear panel connectors

(All connectors are BNC female unless otherwise noted.)¹

Auxiliary interface	Used for RS-232 serial communication and for master/slave
(Dual mode)	source synchronization. (9-pin D-subminiature female
(244	connector) For master/slave operation, use Agilent part
	number 8120-8806 master/slave interface cable.
GPIB	Allows communication with compatible devices
LAN	Allows 10baseT LAN communication
10 MHz input	Accepts an external reference (timebase) input (at 1, 2, 2.5, 5, 10 MHz for standard and 10 MHz only for Option UNR). Nominal input impedance 50 Ω. Damage levels > +10 dBm.
10 MHz output	Outputs internal or external reference signal. Nominal output impedance 50 Ω . Nominal output power +4 dBm.
Sweep output (Dual mode)	Supplies a voltage proportional to the RF power or frequency sweep ranging from 0 volts at the start of sweep to +10 volts (nom) at the end of sweep, regardless of sweep width.
	When connected to an Agilent 8757D scalar network analyzer (Option 007), generates a selectable number of equally spaced 1 µs pulses (nom) across a ramp (analog) sweep. Number of pulses can be set from 101 to 1601 by remote control from the 8757D.
	Output impedance: < 1 Ω (nom), can drive 2000 Ω .
Stop sweep In/Out	Open-collector, TTL-compatible input/output. In ramp sweep operation, provides low level (nominally 0 V) during sweep retrace and bandcross intervals, and high level during the forward portion of the sweep. Sweep will stop when grounded externally; sweep will resume when allowed to
	go high.
Trigger output (dual mode)	Outputs a TTL signal. High at start of dwell, or when waiting for point trigger; low when dwell is over or point trigger is received. In ramp sweep mode, provides 1601 equally-spaced 1 µs pulses (nom) across a ramp sweep. When using LF out, provides 2 µs pulse at start of LF sweep.
Trigger input	Accepts TTL signal for triggering point-to-point in manual sweep mode, or to trigger start of LF sweep. Damage levels
Source module interface	≥ +10 V or ≤ -4 V. Provides bias, flatness correction, and leveling connections to the Agilent model 83550 Series mm-wave source modules.
Source settled	Provides an output trigger that indicates when the signal generator has settled to a new frequency or power level. High indicates source not settled, low indicates source settled.
Z-axis Blank/Markers	During ramp sweep, supplies + 5 V (nom) level during retrace and bandswitch intervals. Supplies – 5 V (nom) level when the RF frequency is at a marker frequency.
EFC	> 0.25 ppm for -5 to $+5$ V Input impedance: > 1 M Ω
.25 – 3.2 GHz coherent	Outputs RF signal modulated with FM or Φ M but not I/Q,
carrier output	AM or pulse. Nominal power 0 dBm. Frequency range from 250 MHz to 3.2 GHz. Not useful for output frequency > 3.2 GHz Damage levels 20 V_{DC} and 13 dBm reverse RF power.
	(SMA female).
Baseband generator	Accepts a sine or square wave PECL clock input with a
clock input	frequency range of 200 MHz o 400 MHz (resulting in sample rates of 50 MSa/s to 100 MSa/s). The recommended input level is approximately 1 V _{peak to peak} for a square wave and 0 dBm to 6 dBm for a sine wave. Allows the baseband generators of multiple signal sources to run off same clock.

Digital inputs and output are 3.3 V CMOS unless indicated otherwise. Inputs will accept 5 V CMOS, 3 V CMOS, or TTL voltage levels.

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Accepts signal for gating burst power for use with internal baseband generator (Option 601 or 602). The burst gating is used when you are externally supplying data and clock information. The input signal must be synchronized with the external data input that will be output during the burst.
The burst power envelope and modulated data are internally delayed and re-synchronized. The input signal must be CMOS high for normal burst RF power or CW RF output power and CMOS low for RF off. Damage levels are
> +5.5 V and < -0.5 V.
In real-time mode, outputs a pattern or frame synchronization pulse for triggering or gating external equipment, for use with internal baseband generator (Option 601 or 602). May be set to start at the beginning of a pattern, frame, or timeslot and is adjustable to within \pm one timeslot with one bit resolution. In arbitrary waveform mode, outputs a timing signal generated by marker 1.
In real-time mode, outputs a data enable signal for gating external equipment, for use with internal baseband generator (Option 601 or 602). Applicable when external data is clocked into internally generated timeslots. Data is enabled when signal is low. In arbitrary waveform mode, outputs a timing signal generated by marker 2.
Outputs the analog I/Q modulation signals from the internal baseband generator. Nominal output impedance 50 Ω, DC-coupled. Damage levels ±3.5 V.
Outputs the complement of the I and Ω signals for differential applications. Nominal output impedance 50 Ω, DC-coupled. Damage levels ±3.5 V.
Accepts signal to trigger internal pattern or frame generator to start single pattern output, for use with internal baseband generator (Option 601 or 602). Minimum pulse width 100 ns. Damage levels are > +5.5 V and < -0.5 V.
Direct high-bandwidth analog inputs to I/Q modulator in 3.2 to 44 GHz range. Not calibrated. 0 dBm maximum. (Option 015 only).
Accepts CMOS signal for synchronization of external data and alternate power signal timing. Damage levels are > +8 V and < -4V.
Relays a CMOS bit clock signal for synchronizing serial data.
Outputs data from the internal data generator or the externally supplied signal at data input. CMOS signal.
In arbitrary waveform mode, outputs a timing signal generated by marker 3. Damage levels > +8 V and < 4 V.
In arbitrary waveform mode, outputs a timing signal generated by marker 4. Damage levels > +8 V and < 4 V.
Outputs CMOS symbol clock for symbol synchronization, one data clock period wide.

Auxiliary I/O connector (37-pin) used with Option 601 or 602

Options, Accessories, and Related Products

Model/option	Description
E8267D-520	Frequency range from 250 kHz to 20 GHz
E8267D-532	Frequency range from 250 kHz to 31.8 GHz
E8267D-544	Frequency range from 250 kHz to 44 GHz
E8267D-601	Internal baseband generator, 8 MSa memory
E8267D-602	Internal baseband generator, 64 MSa memory
E8267D-003	PSG digital output connectivity with N5102A
E8267D-004	PSG digital input connectivity with N5102A
E8267D-005	6 GB internal hard drive
E8267D-007	Analog ramp sweep
E8267D-015	Wideband external I/Q inputs
E8267D-408	Signal Studio for enhanced multitone
E8267D-420	Signal Studio for pulse building
E8267D-421	Signal Studio for noise power ratio
E8267D-H17	Signal Studio for 802.11 WLAN
E8267D-SP1	Signal Studio for jitter injection
E8267D-UNR	Enhanced phase noise performance
E8267D-UNT	AM, FM, phase modulation, and LF output
E8267D-UNU	Pulse modulation
E8267D-UNW	Narrow pulse modulation
E8267D-1ED	Type-N (f) RF output connector
E8267D-1EH	Improved harmonics below 2 GHz
E8267D-1EM	Moves all front panel connectors to the rear panel
E8267D-SP2	Dynamic sequencing capability
E8267D-HCC	Local oscillator access ¹
E8267D-1CN	Front handle kit
E8267D-1CM	Rackmount flange kit
E8267D-1CP	Rackmount flange and front handle kit
E8267D-UK6	Commercial calibration certificate and test data
E8267D-CD1	CD-ROM containing the English documentation set
E8267D-ABA	Printed copy of the English documentation set
E8267D-0BW	Printed copy of the assembly-level service guide
N5102A	Baseband Studio digital signal interface module
N5101A	Baseband Studio PCI card
N5110B	Baseband Studio for waveform capture and playback
N5110B-194	Play waveform from Baseband Studio PCI card
N5110B-195	Capture waveform to Baseband Studio PCI card
N5110B-130	40 MSa/s sample rate
N5110B-132	100 MSa/s sample rate
N5110B-134	200 MSa/s sample rate
Z5623A-K03	Distribution amplifier, 250 MHz to 4 GHz ¹ Distribution amplifier, 3.2 GHz to 10 GHz ¹
Z5623A-K05	Master/slave interface cable
8120-8806 9211-2656	Transit case
9211-2656 9211-7481	Transit case
JZ11-7401	Hansil Lase Willi Wileels

1. Utilized for multiple source phase coherency applications.

Web Resources

For additional product information, visit: www.agilent.com/find/psg

For information about renting, leasing or financing Agilent's latest technology, visit: www.agilent.com/find/buy/alternatives

For accessory information, visit: www.agilent.com/find/accessories

For additional description of Agilent's IO Libraries Suite features and installation requirements, please go to: www.agilent.com/find/iosuite/database

Related Agilent Literature

PSG Self Guided Demo Literature number 5988-2414EN

E8267D PSG Vector Signal Generator Configuration Guide, Literature number 5989-1326EN

E8257D PSG Analog Signal Generator Data Sheet, Literature number 5989-0698EN

Millimeter Wave Source Modules Product Note, Literature number 5988-2567EN

PSG Two-tone and Multitone Personalities Application Note AN 1410, Literature number 5988-7689EN

Signal Studio for Noise Power Ratio Technical Overview, Literature number 5988-9161EN

Signal Studio for Enhanced Multitone Technical Overview, Literature number 5988-5639EN

Signal Studio for 802.11 WLAN Technical Overview, Literature number 5988-8618EN

Baseband Studio Digital Signal Interface Module Technical Overview, Literature number 5988-9495EN

Baseband Studio for Waveform Streaming Technical Overview, Literature number 5988-9493EN

Security of Agilent Signal Generators: Issues and Solutions Literature number 5989-1091EN

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